nexperia

Quarterly Reliability Monitoring Results

Quarters: Q3/2021 to Q4/2022 Based on structural similarity

Supplier		User Part Number				
Nexperia B.V. Name of Laboratory Assembly reliability labs Based on AEC-Q101 Test		PZU3.0B1A-Q Part Description				
		SMD package				
		Test Conditions	Duration	# Lots	# Quantity	# Rejects
			TEST			
	Pre- and Post-Stress					
# E1	Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below
		JESD22-A113				
		Bake Tamb = 125 °C	24 hours			
	PC	Soak Tamb = 85 °C, RH = 85%	168 hours			
# A1	Preconditioning	Reflow soldering	3 cycles	1168	66640	0
		MIL-STD-750-1				
	HTRB	M1038 Method A				
	5 ,	Tj = Tjmax, VR = 80 % of rated reverse				
# B1	Bias	voltage	1000 hours	198	11960	0
		MIL-STD-750-1				
		M1038 Method B				
	SSOP	Tj = Tjmax, Iz = 100% of max. datasheet				
# B1b	Steady State Operational	reverse current	1000 hours	24	1760	0
	тс	JESD22-A104				
# A4	Temperature Cycling	-65 °C to Tjmax, not to exceed 150°C	1000 cycles	240	14800	0
	UHAST	JESD22-A118				
# A3 or	Unbiased HAST	Tamb = $130 ^{\circ}$ C, RH = $85 ^{\circ}$				
# A3 U	Unblased HAST		— 96 hours	240	14800	0
	AC	JESD22-A102 Tamb = 121 °C, RH = 100 %				
# A3 alt	Autoclave	Pressure = 205 kPa (29.7 psia)				
# A5 dil	Autoclave	riessure – 203 kra (23.7 psia)				
	H3TRB	JESD22-A101				
	High Humidity High	Tamb = $85 ^{\circ}$ C, RH = 85% , VR = 80% of				
# A2 alt		rated reverse voltage ^[1]	1000 hours	240	14800	0
<i>π r</i> ι∠ αιι	Temperature Reverse Dias	MIL-STD-750 Method 1037	1000 1100/5	240	14000	U
	IOL	ton = toff, devices powered to insure ΔT_j =				
# A5	Intermittent Operating Life		1000 hours	264	16720	0
	inconnicient operating Life		1000 1100/5	207	10/20	0
	RSH	JESD22-A111				
# C8	Resistance to Solder Heat	$260 \text{ °C} \pm 5 \text{ °C}$	10 s	184	5520	0
	SD		10.3	104	3320	0
# C10	Solderability	J-STD-002		501	5010	0
# CIU	conder domey	5 5.5 552		201	2010	v

[1] The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test #B1) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

2,82E+09

© 2023 Nexperia B.V.

All information hereunder is per Nexperia's best knowledge. This document does not provide for any representation or warranty express or implied by Nexperia. In case Nexperia has tested the product, this documentation reflects the outcome of the analysis of the actually tested parts only.

nexperia.com